TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOS V-H)

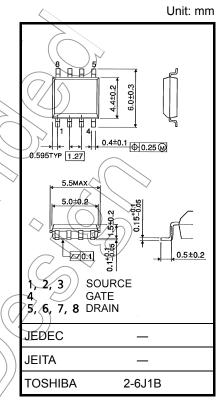
# ТРС8037-Н

High-Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: QSW = 5.0 nC (typ.)
- Low drain-source ON-resistance:  $R_{DS}$  (ON) = 7.6 m $\Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 36 \text{ S} (typ.)$
- Low leakage current:  $I_{DSS} = 10 \ \mu A \ (max) \ (V_{DS} = 30 \ V)$
- Enhancement mode:  $V_{th} = 1.5$  to 2.5 V ( $V_{DS} = 10$  V,  $I_D = 1$  mÅ)

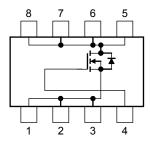
#### Absolute Maximum Ratings (Ta = 25°C)

			$( \bigcirc )$	*
Characteristic		Symbol	Rating	⊖ Unit
Drain-source voltage		V <sub>DSS</sub>	30	V
Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ )		V <sub>DGR (</sub>	30	V
Gate-source voltage		V <sub>GSS</sub>	<u>+</u> 20	< <v td="" y<=""></v>
Drain current	DC (Note 1)	ID	12	A
	Pulsed (Note 1)	LDR	48	
Drain power dissipation $(t = 10 s)$			1.9	w
	(Note 2a)		//	
Drain power dissipation (t = 10 s) (Note 2b)		Po	1.0	Ŵ
Single-pulse avalanch	ne energy (Note 3)	EAS	94	mJ
Avalanche current		IAR	12	A
Repetitive avalarche energy		EAR	0.18	mJ
Channel temperature		( <sup>Ti</sup> ch	150	°C
Storage temperature range		Tstg	-55 to 150	°C



Weight: 0.085 g (typ.)

#### **Circuit Configuration**



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

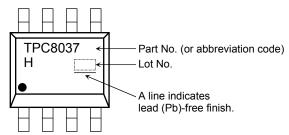
This transistor is an electrostatic-sensitive device. Handle with care.

# TOSHIBA

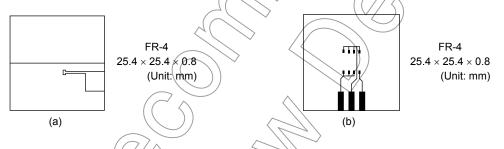
## **Thermal Characteristics**

Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	65.8	°C/W	
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	125	°C/W	

## Marking (Note 5)

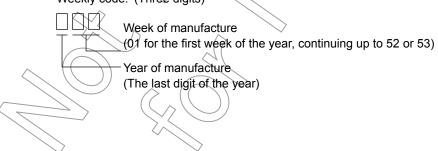


- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: (a) Device mounted on a glass-epoxy board (a)



(b) Device mounted on a glass-epoxy board (b)

- Note 3:  $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ} \text{ C}$  (initial),  $L = 500 \text{ }\mu\text{H}, \text{ R}_{G} = 25 \Omega, \text{ I}_{AR} = 12 \text{ A}$
- Note 4: Repetitive rating: pulse width limited by maximum channel temperature
- Note 5: on lower left of the marking indicates Pin 1.
  - \* Weekly code: (Three digits)



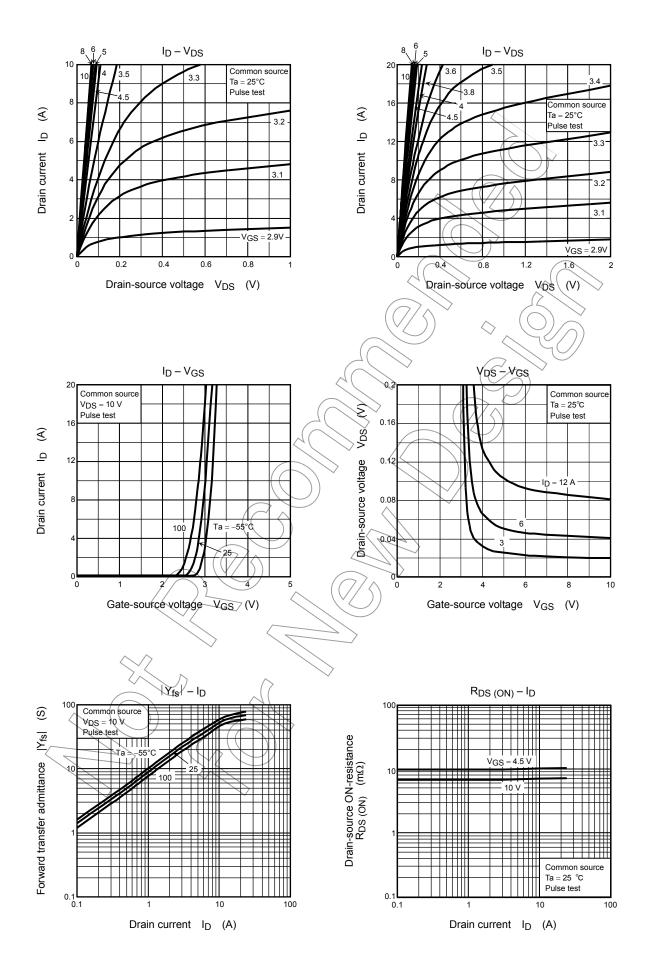
**Electrical Characteristics (Ta = 25°C)** 

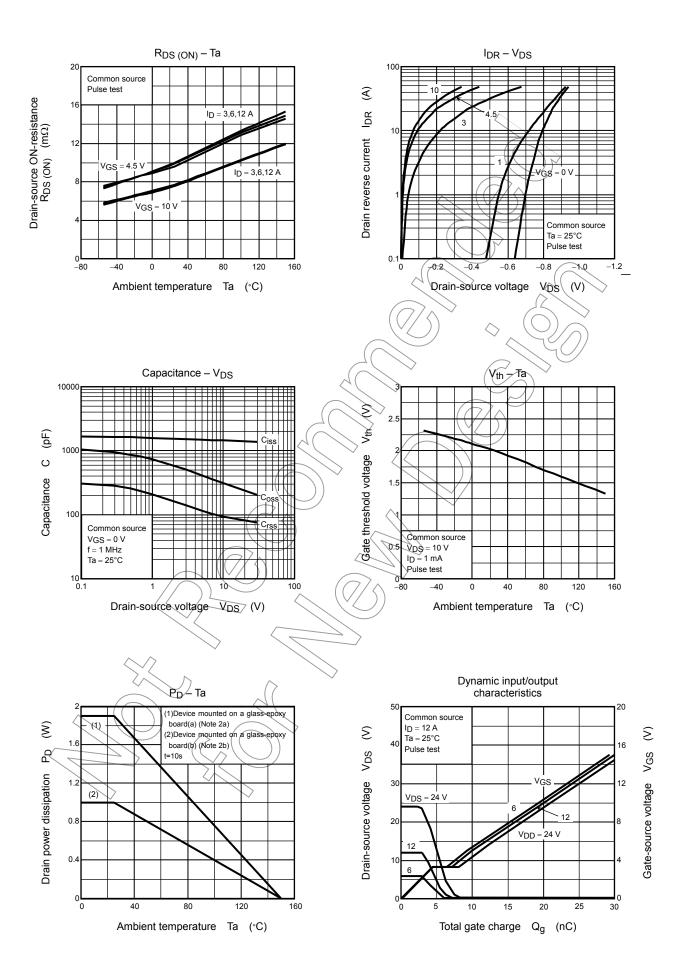
Ch	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage cur	rent	I <sub>GSS</sub>	$V_{GS}=\pm 20~V,~V_{DS}=0~V$	_	—	±100	nA	
Drain cutoff curre	ent	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μA	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	—	_	V	
		V (BR) DSX	$_{\rm D}$ = 10 mA, V <sub>GS</sub> = -20 V 15			_	v	
Gate threshold vo	oltage	V <sub>th</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.5		2.5	V	
Drain-source ON-resistance		R <sub>DS (ON)</sub>	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	2	9.9	13.9	mΩ	
			$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	$\mathcal{A}$	7.6	11.4		
Forward transfer	admittance	Y <sub>fs</sub>	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$	18	36	_	S	
Input capacitance		C <sub>iss</sub>			1433	2150		
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	83	125	pF	
Output capacitance		C <sub>oss</sub>			< 303	$\searrow$		
Gate resistance		Rg	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 5 \text{ MHz}$	-6	1.0	> 1.5	Ω	
Switching time	Rise time	tr	$10\sqrt{10}$ $I_D = 6 A$	K	3	) _	20	
	Turn-on time	t <sub>on</sub>	$V_{GS} \xrightarrow{10} V \xrightarrow{10} V_{OUT}$		10	_		
	Fall time	t <sub>f</sub>			3.9	_	– ns	
	Turn-off time	toff	Duty $\leq$ 1%, t <sub>w</sub> = 10 µs	_	23	_		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \approx 24 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 12 \text{ A}$		21	_		
			$V_{DD} \approx 24 \text{ V}, \text{ V}_{GS} = 5 \text{ V}, \text{ I}_{D} \neq 12 \text{ A}$		11	_		
Gate-source char	rge 1	Qĝs1			4.4	_	nC	
Gate-drain ("Miller") charge		Qgđ	$V_{DD} \approx 24 V, V_{GS} = 10 V, I_D = 12 A$		3.7	_		
Gate switch charge		Qsw		_	5.0	_		

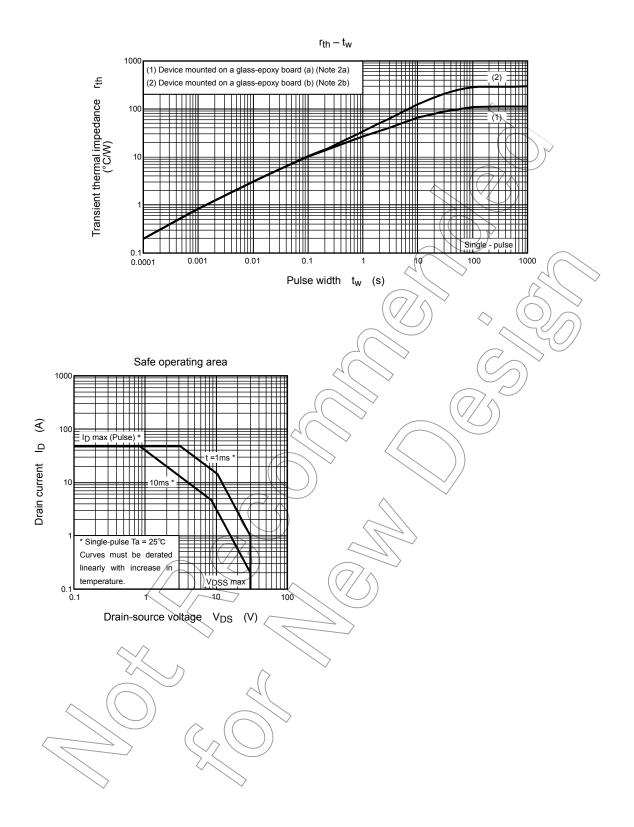
# Source-Drain Ratings and Characteristics (Ta $= 25^{\circ}$ C)

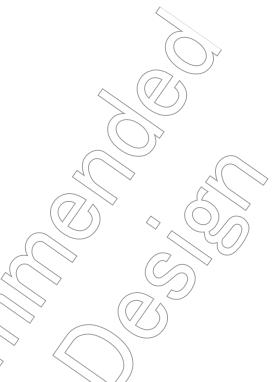
Characteristic	Symbol	Min	Тур.	Max	Unit	
Drain reverse current Pulse (Note 1)	IDRP	—	_	_	48	А
Forward voltage (diode)	$V_{\text{DSF}}$ $I_{\text{DR}} = 12$	2 A, V <sub>GS</sub> = 0 V	_	_	-1.2	V

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set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.

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